

# Search Notes



Application No.

09/840,071

Examiner

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Applicant(s)

ARITA ET AL.

Art Unit

3629

## SEARCHED

	Class	Subclass	Date	Examiner
①	705	1	5/1/05	Don
		412	5/14/05	Don
②	702	57 <sup>x</sup>		
		62 <sup>x</sup>		
③	324	142		
④	307	42		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
I US	5/15/05	Don
Patent		
PG Pub		
II FOREIGN		
1. EPO		
2. JPO		
3. Derwent		